

Notice of References Cited	Application/Control No. 10/593,848		Applicant(s)/Patent Under Reexamination LEE ET AL.	
	Examiner OOMMEN JACOB		Art Unit 2613	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2001/0038479	11-2001	Liu et al.	359/127
*	B	US-2004/0264963	12-2004	Kani et al.	398/072
	C	US-			
	D	US-			
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	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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*	N	WO 03055111 A1	07-2003	World Intellect	TERVONEN et al.	
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	R					
	S					
	I					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
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